## Notice of References Cited Application/Control No. O9/282,285 Examiner Son P Huynh Applicant(s)/Patent Under Reexamination FEINLEIB ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2001/0014914	08-2001	MURAMATSU et al.	709/224
	В	US-2002/0069113	06-2002	STERN, MICHAEL	705/26
	С	US-6,427,238	07-2002	Goodman et al.	725/136
	D	US-6,029,045	02-2000	Picco et al.	725/34
	Ε	US-5,619,250	04-1997	McClellan et al.	725/132
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	۲	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р	_				
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

_		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.